

Notice of References Cited	Application/Control No. 10/586,682		Applicant(s)/Patent Under Reexamination LEYRER ET AL.	
	Examiner HUI CHIN		Art Unit 1796	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0090611	04-2005	Huffer et al.	524/800
*	B	US-2004/0171759	09-2004	Lange et al.	525/192
*	C	US-2003/0225168	12-2003	Deroo et al.	516/77
*	D	US-6,677,293	01-2004	Allgaier et al.	510/417
*	E	US-2003/0129151	07-2003	Candau et al.	424/59
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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